

APPROVAL SHEET

WLBD3216 Chip Bead

*Contents in this sheet are subject to change without prior notice.



FEATURES

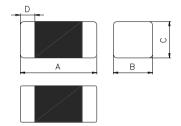
1. Closed magnetic circuit.

APPLICATIONS

1. Noise reduction for general signal and DC line for General electronic circuits. Ex:PCs · Networking and Consumer electronics.

SHAPE and DIMENSION





Chip Size				
Α	3.20±0.20			
В	1.60±0.20			
С	1.10±0.20			
D	0.50±0.30			

Units: mm

Ordering Information

WL	BD	3216	K1	U	260	Т	В
Product Code	Series	Dimensions	Series extension	Tolerance	Value	Packing Code	
WL: Inductor	BD :Chip Bead.	3.2 * 1.6 mm 3216 :EIA 1206	Refer to characteristic	U: ±25%	260 =26 OHM 221 =220 OHM	P = 7" Plastic Tape	B:STD

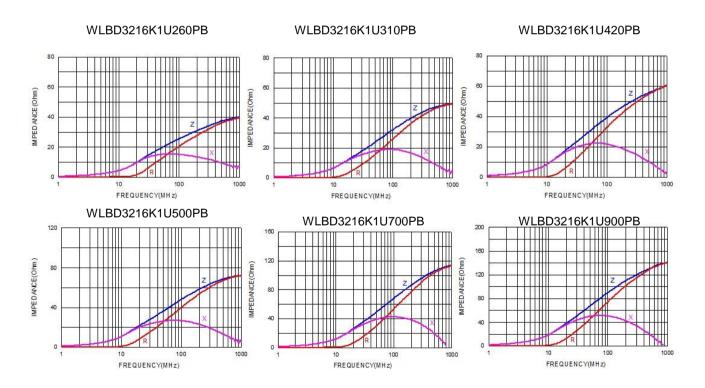


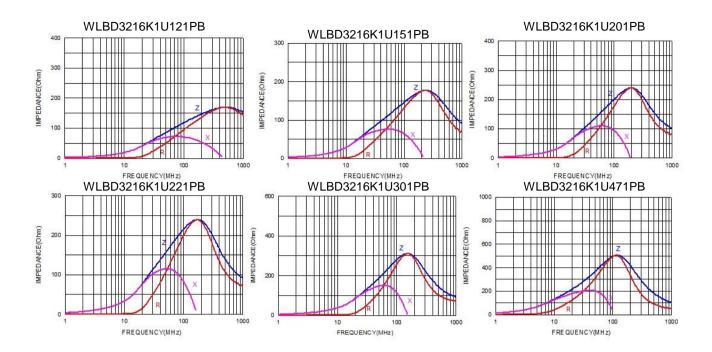
Electrical Characteristics

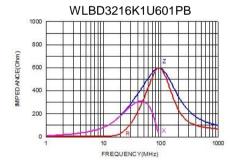
WLBD3216 series

Walsin Part Number	Impedance (Ω)	Test Frequency (MHz)	DC Resistance (Ω) max.	Rated Current (mA) max.
WLBD3216K1U260PB	26±25%	100	0.20	500
WLBD3216K1U310PB	31±25%	100	0.20	500
WLBD3216K1U420PB	42±25%	100	0.20	500
WLBD3216K1U500PB	50±25%	100	0.20	500
WLBD3216K1U700PB	70±25%	100	0.20	500
WLBD3216K1U900PB	90±25%	100	0.20	500
WLBD3216K1U121PB	120±25%	100	0.15	900
WLBD3216K1U151PB	150±25%	100	0.15	900
WLBD3216K1U201PB	200±25%	100	0.35	600
WLBD3216K1U221PB	220±25%	100	0.35	700
WLBD3216K1U301PB	300±25%	100	0.35	700
WLBD3216K1U471PB	470±25%	100	0.35	400
WLBD3216K1U601PB	600±25%	100	0.40	400

Characteristic Curve









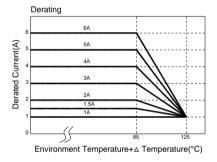
Test condition & Requirements

Item	Performance	Test Condition				
Operating Temperature	-40~+125℃ (Including self-temperature rise)					
Transportation Storage Temperature	-40~+125℃ (on board)	For long storage conditions, please see Application Notice				see the
Impedance (Z)		Agilent42	91			
Inductance (Ls)		Agilent E	4991			
Q Factor		Agilent42	87			
	Refer to standard electrical characteristics list					
DC Resistance		Agilent 4338				
Rated Current		DC Powe Over Rat be some	ted Cu		uirements, t	there will
Temperature Rise Test	Rated Current < 1A ΔT 20 $^{\circ}$ Max Rated Current \geq 1A ΔT 40 $^{\circ}$ Max	2. Tempe			current. I by digital s	urface
		Number o	of heat	cycles: 1		
		Tempera (°C		Time (s)	Temperation ramp/imme and emers	ersion
Decistance to Calderine	Appearance : No damage. Impedance : within±15% of initial value	260 ±5 (solder te	emp)	10 ±1	25mm/s :	±6 mm/s
Resistance to Soldering Heat	Inductance: within±10% of initial value Inductance: within±10% of initial value Q: Shall not exceed the specification value. RDC: within ±15% of initial value and shall not exceed the specification value		omplete	ely cover t	he terminati	on
Solderability	More than 95% of the terminal electrode should be covered with solder.	Preheat: 150°C,60sec. Solder: Sn96.5%-Ag3%-Cu0.5% Solder temperature: 245±5°C Flux for lead free: Rosin. 9.5% Depth: completely cover the termination. Dip time: 4±1sec.			on.	
Terminal strength	Appearance : No damage. Impedance : within±15% of initial value Inductance : within±10% of initial value Q : Shall not exceed the specification value. RDC : within±15% of initial value and shall not exceed the specification value	Preconditioning: Run through IR reflow for times.(IPC/JEDEC J-STD-020D Classification Reflow Profiles) Component mounted on a PCB apply a force (>0805:1kg <=0805:0.5kg)to the side of device being tested. This force shall be applied for 60 +1 seconds. Also the force shall be applied gradually as not to shock the component being tested.			sification y a force ide of a shall be the force	
Bending	Appearance: No damage. Impedance: within±10% of initial value Inductance: within±10% of initial value Q: Shall not exceed the specification value. RDC: within ±15% of initial value and shall not exceed the specification value	Shall be mounted on a FR4 substrate of the following dimensions:>=0805:40x100x1.2mm <0805:40x100x0.8mm Bending depth:>=0805:1.2mm <0805:0.8mm Duration of 10 sec for a min.			x1.2mm	
Vibration Test	Appearance: No damage. Impedance: within±15% of initial value Inductance: within±10% of initial value Q: Shall not exceed the specification value. RDC: within ±15% of initial value and shall not exceed the specification value	Preconditioning: Run through IR reflow for times.(IPC/JEDEC J-STD-020D Classification Reflow Profiles) Oscillation Frequency: 10~2K~10Hz for similates Equipment: Vibration checker Total Amplitude:1.52mm±10% Testing Time: 12 hours(20 minutes, 12 cycle each of 3 orientations)			sification	
Shock	Appearance: No damage. Impedance: within±10% of initial value Inductance: within±10% of initial value Q: Shall not exceed the specification value.	Test cor	Peak Value (g's)	Normal duration (D) (ms)	Wave form	Velocity change (Vi)ft/sec 11.3
	RDC: within ±15% of initial value and shall not exceed the specification value	Lead	50	11	Half-sine	11.3
		Leau	50	111	i iaii-sii le	11.3

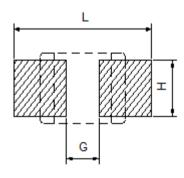
Item	Performance	Test Condition
Life test	Appearance: no damage. Impedance: within±15%of initial value. Inductance: within±10%of initial value. Q: Shall not exceed the specification value. RDC: within ±15% of initial value and shall not exceed the specification value	Preconditioning: Run through IR reflow for 2 times.(IPC/JEDEC J-STD-020D Classification Reflow Profiles) Temperature: 125±2°C (bead), 105±2°C (Inductor)) Applied current: rated current. Duration: 1000±12hrs. Measured at room temperature after placing for 24±2 hrs.
Load Humidity		Preconditioning: Run through IR reflow for 2 times.(IPC/JEDEC J-STD-020D Classification Reflow Profiles) Humidity: 85±2%R.H. Temperature: 85±2℃. Duration: 1000hrs Min. with 100% rated current. Measured at room temperature after placing for 24±2 hrs.
Thermal shock	Appearance: no damage. Impedance: within±15%of initial value. Inductance: within±10%of initial value. Q: Shall not exceed the specification value. RDC: within ±15% of initial value and shall not exceed the specification value	Preconditioning: Run through IR reflow for 2 times.(IPC/JEDEC J-STD-020D Classification Reflow Profiles) Condition for 1 cycle Step1: -40±2°C 30±5 min. Step2: 25±2°C ≤0.5min Step3: +125±2°C 30±5min. (Bead) Step3: +105±2°C 30±5min. (Inductor) Number of cycles: 500 Measured at room temperature after placing for 24±2 hrs.

**Derating Curve

For the ferrite chip bead which withstanding current over 1.5A, as the operating temperature over $85^{\circ}\mathrm{C}$, the derating current information is necessary to consider with. For the detail derating of current, please refer to the Derated Current vs. Operating Temperature curve.



Soldering and Mounting



	L (mm)	G (mm)	H (mm)
WLBD3216	4.40	2.20	1.40



Soldering

Mildly activated rosin fluxes are preferred. The terminations are suitable for re-flow soldering systems. If hand soldering cannot be avoided, the preferred technique is the utilization of hot air soldering tools.

Note. If wave soldering is used ,there will be some risk.

Re-flow soldering temperatures below 240 degrees, there will be non-wetting risk

Lead Free Solder re-flow

Recommended temperature profiles for lead free re-flow soldering in Figure 1. (Refered to J-STD-020C)

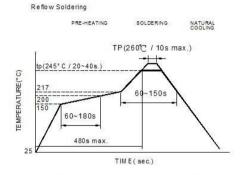
Soldering Iron:

Products attachment with a soldering iron is discouraged due to the inherent process control limitations. If a soldering iron must be employed the following precautions are recommended. for Iron Soldering in Figure 2.

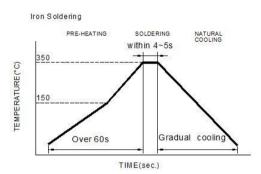
Preheat circuit and products to 150°C

· 350°C tip temperature (max)

- C
- · Never contact the ceramic with the iron tip
 - 1.0mm tip diameter (max)
- Use a 20 watt soldering iron with tip diameter of 1.0mm
- · Limit soldering time to 4~5sec.



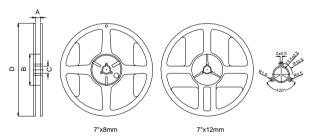
Reflow times: 3 times max-Fig.1



Iron Soldering times: 1 times max-Fig.2

Packaging Specification

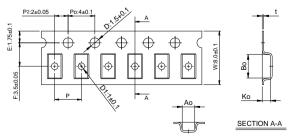
Reel Dimension



Туре	A(mm)	B(mm)	C(mm)	D(mm)
7"x8mm	9.0±0.5	60±2	13.5±0.5	178±2
7"x12mm	13.5±0.5	60±2	13.5±0.5	178±2

Tape Dimension / 8mm

■Material of taping is plastic



Size	Bo(mm)	Ao(mm)	Ko(mm)	P(mm)	t(mm)	D1(mm)
WLBD3216	3.35±0.10	1.75±0.10	1.25±0.10	4.0±0.10	0.23±0.05	1.0±0.10